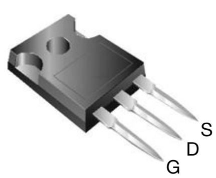
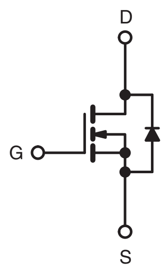
Power MOSFET

PRODUCT SUMMARY		
V_{DS} (V)	500	
$R_{DS(on)}$ (Ω)	V_{GS} = 10 V	0.28
Q_g (Max.) (nC)	130	
Q_{gs} (nC)	33	
Q_{gd} (nC)	59	
Configuration	Single	

TO-247AC





N-Channel MOSFET

FEATURES

- SuperFast Body Diode Eliminates the Need For External Diodes in ZVS Applications
- Low Gate Charge Results in Simple Drive Requirement
- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise Immunity
- Compliant to RoHS Directive 2002/95/EC

Pb Available

RoHS* COMPLIANT

APPLICATIONS

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supply
- Motor Control applications

ORDERING INFORMATION	
Package	TO-247AC
Lead (Pb)-free	IRFP17N50LPbF
	SiHFP17N50L-E3
SnPb	IRFP17N50L
	SiHFP17N50L

ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C, unless otherwise noted)

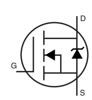
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V_{DS}	500	V
Gate-Source Voltage			V_{GS}	± 30	
Continuous Drain Current	V_{GS} at 10 V	T_C = 25 °C	I_D	16	A
		T_C = 100 °C		11	
Pulsed Drain Current[a]			I_{DM}	64	
Linear Derating Factor				1.8	W/°C
Single Pulse Avalanche Energy[b]			E_{AS}	390	mJ
Repetitive Avalanche Current[a]			I_{AR}	16	A
Repetitive Avalanche Energy[a]			E_{AR}	22	mJ
Maximum Power Dissipation	T_C = 25 °C		P_D	220	W
Peak Diode Recovery dV/dt[c]			dV/dt	13	V/ns
Operating Junction and Storage Temperature Range			T_J, T_{stg}	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)	for 10 s			300[d]	
Mounting Torque	6-32 or M3 screw			10	lbf · in
				1.1	N · m

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Starting T_J = 25 °C, L = 3.0 mH, R_g = 25 Ω, I_{AS} = 16 A (see fig. 12).
c. $I_{SD} \leq$ 16 A, dI/dt $\leq$ 347 A/μs, $V_{DD} \leq V_{DS}$, $T_J \leq$ 150 °C.
d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS				
PARAMETER	**SYMBOL**	**TYP.**	**MAX.**	**UNIT**
Maximum Junction-to-Ambient	R_{thJA}	-	62	°C/W
Case-to-Sink, Flat, Greased Surface	R_{thCS}	0.50	-	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	0.56	

SPECIFICATIONS (T_J = 25 °C, unless otherwise noted)							
PARAMETER	**SYMBOL**	**TEST CONDITIONS**		**MIN.**	**TYP.**	**MAX.**	**UNIT**
Static							
Drain-Source Breakdown Voltage	V_{DS}	V_{GS} = 0 V, I_D = 250 μA		500	-	-	V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25 °C, I_D = 1 mA[d]		-	0.60	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250 μA		3.0	-	5.0	V
Gate-Source Leakage	I_{GSS}	V_{GS} = ± 30 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 500 V, V_{GS} = 0 V		-	-	50	μA
		V_{DS} = 400 V, V_{GS} = 0 V, T_J = 125 °C		-	-	2.0	mA
Drain-Source On-State Resistance	$R_{DS(on)}$	V_{GS} = 10 V	I_D = 9.9 A[b]	-	0.28	0.32	Ω
Forward Transconductance	g_{fs}	V_{DS} = 50 V, I_D = 9.9 A[b]		11	-	-	S
Dynamic							
Input Capacitance	C_{iss}	V_{GS} = 0 V, V_{DS} = 25 V, f = 1.0 MHz, see fig. 5		-	2760	-	pF
Output Capacitance	C_{oss}			-	325	-	
Reverse Transfer Capacitance	C_{rss}			-	37	-	
Output Capacitance	C_{oss}	V_{GS} = 0 V	V_{DS} = 1.0 V , f = 1.0 MHz	-	3690	-	
			V_{DS} = 400 V , f = 1.0 MHz	-	84	-	
Effective Output Capacitance	C_{oss} eff.		V_{DS} = 0 V to 400 V	-	159	-	
Effective Output Capacitance (Energy Related)	C_{oss} eff. (ER)			-	120	-	
Internal Gate Resistance	R_g	f = 1 MHz, open drain		-	1.4	-	Ω
Total Gate Charge	Q_g	V_{GS} = 10 V	I_D = 16 A, V_{DS} = 400 V see fig. 7 and 15[b]	-	-	130	nC
Gate-Source Charge	Q_{gs}			-	-	33	
Gate-Drain Charge	Q_{gd}			-	-	59	
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 250 V, I_D = 16 A R_G = 7.5 Ω, V_{GS} = 10 V see fig. 14a and 14b[b]		-	21	-	ns
Rise Time	t_r			-	51	-	
Turn-Off Delay Time	$t_{d(off)}$			-	50	-	
Fall Time	t_f			-	28	-	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I_S	MOSFET symbol showing the integral reverse p - n junction diode 		-	-	16	A
Pulsed Diode Forward Current[a]	I_{SM}			-	-	64	
Body Diode Voltage	V_{SD}	T_J = 25 °C, I_S = 16 A, V_{GS} = 0 V[b]		-	-	1.5	V
Body Diode Reverse Recovery Time	t_{rr}	T_J = 25 °C	I_F = 16 A, dI/dt = 100 A/μs[b]	-	170	250	ns
		T_J = 125 °C		-	220	330	
Body Diode Reverse Recovery Charge	Q_{rr}	T_J = 25 °C		-	470	710	μC
		T_J = 125 °C		-	810	1210	
Reverse Recovery Current	I_{RRM}	T_J = 25 °C		-	7.3	11	
Forward Turn-On Time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)					

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.
c. C_{OSS} eff. is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising fom 0 % to 80 % V_{DS}.
   C_{OSS} eff. (ER) is a fixed capacitance that stores the same energy as C_{OSS} while V_{DS} is rising fom 0 % to 80 % V_{DS}.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

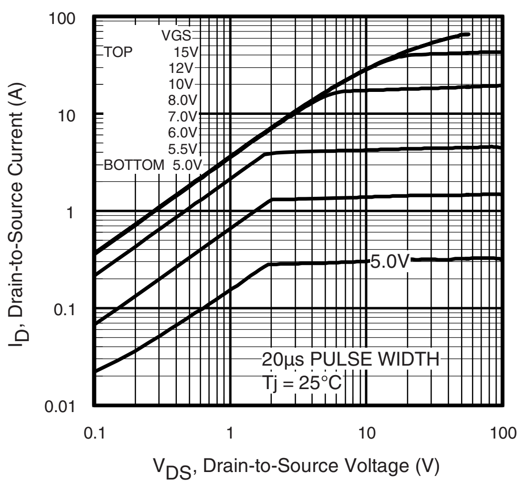


Fig. 1 - Typical Output Characteristics

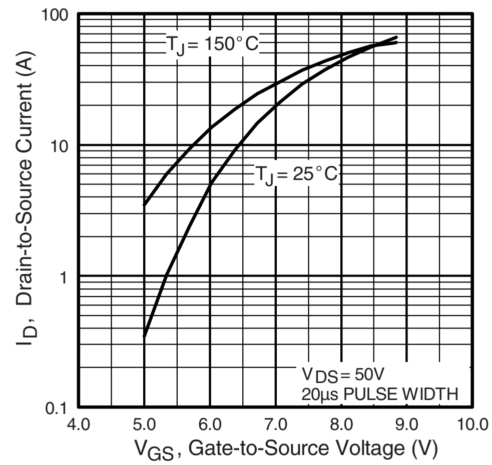


Fig. 3 - Typical Transfer Characteristics

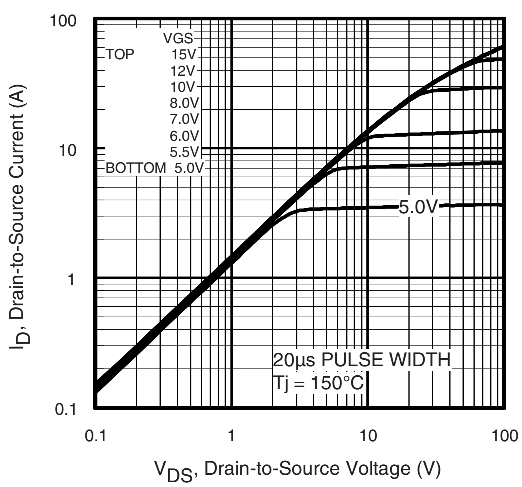


Fig. 2 - Typical Output Characteristics

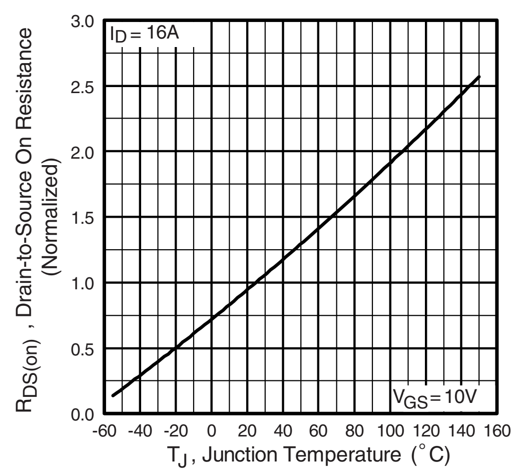


Fig. 4 - Normalized On-Resistance vs. Temperature

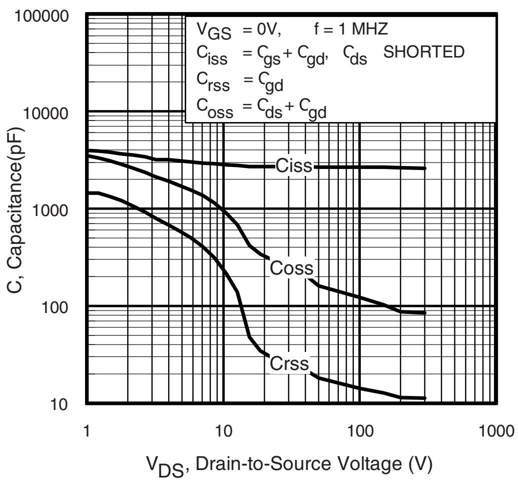


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

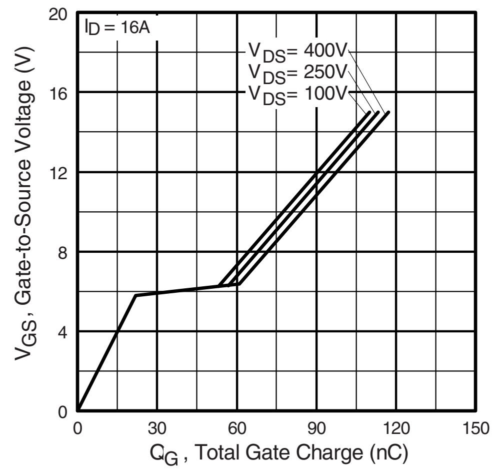


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

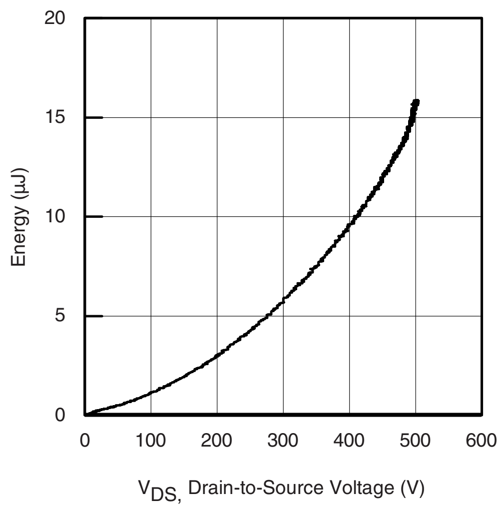


Fig. 6 - Typ. Output Capacitance Stored Energy vs. V_{DS}

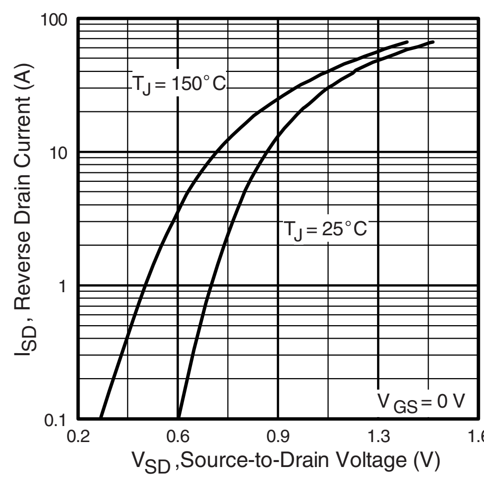


Fig. 8 - Typical Source-Drain Diode Forward Voltage

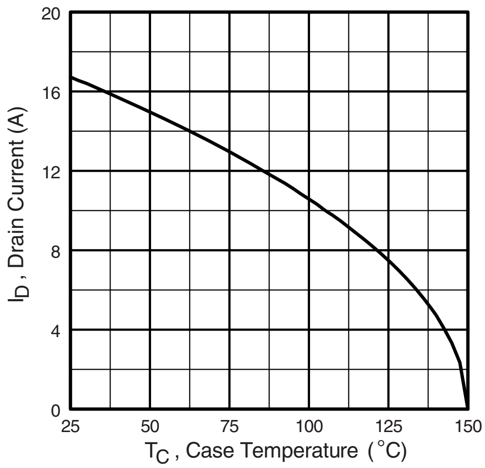


Fig. 9 - Maximum Drain Current vs. Case Temperature

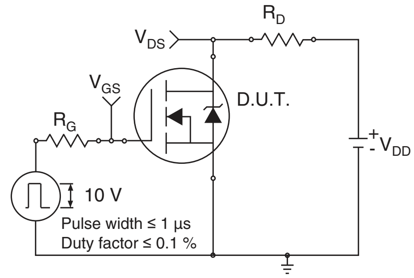


Fig. 10a - Switching Time Test Circuit

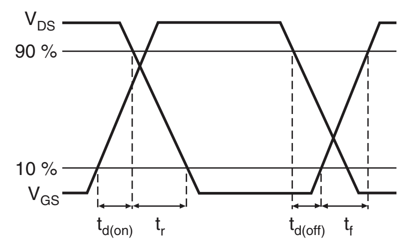


Fig. 10b - Switching Time Waveforms

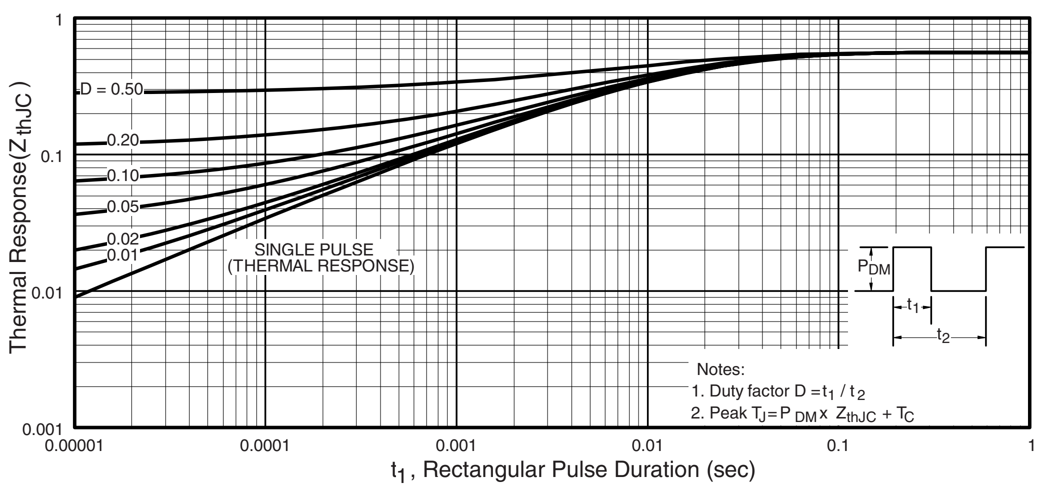


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

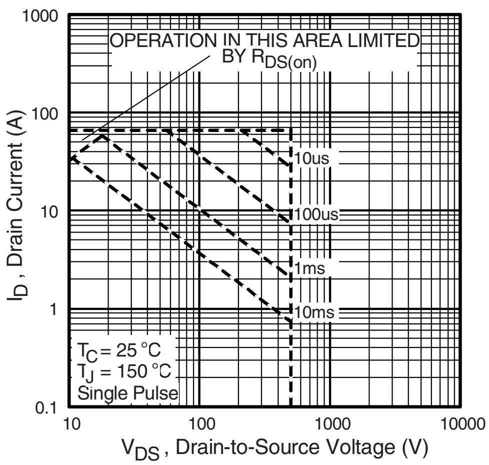


Fig. 12 - Maximum Safe Operating Area

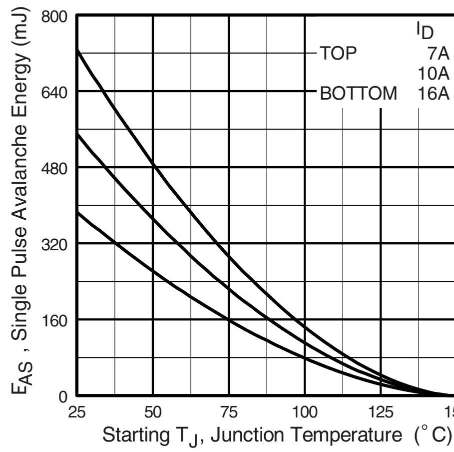


Fig. 13 - Maximum Avalanche Energy vs. Drain Current

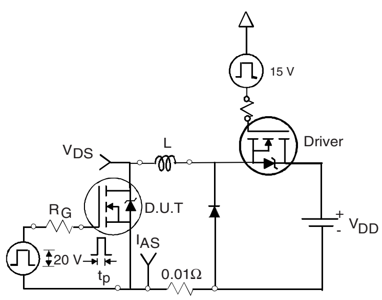


Fig. 14a - Unclamped Inductive Test Circuit

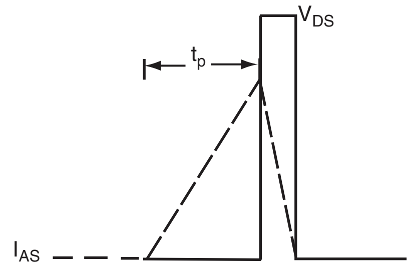


Fig. 14b - Unclamped Inductive Waveforms

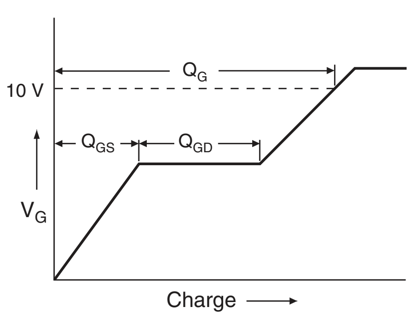


Fig. 15a - Basic Gate Charge Waveform

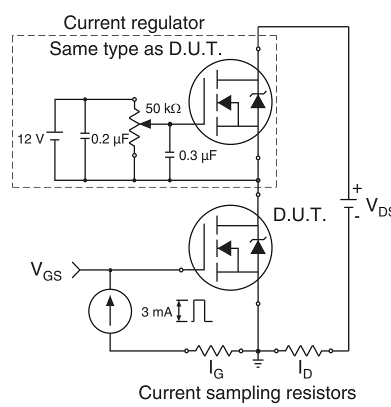
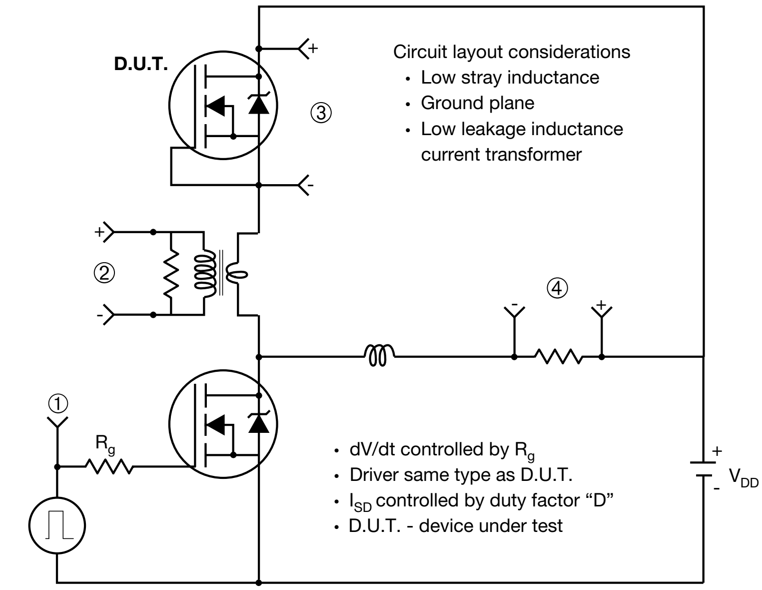
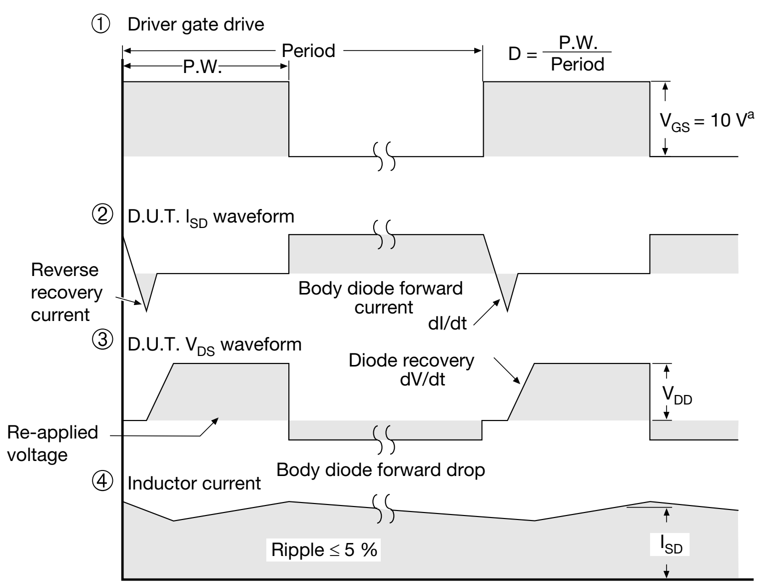


Fig. 15b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit





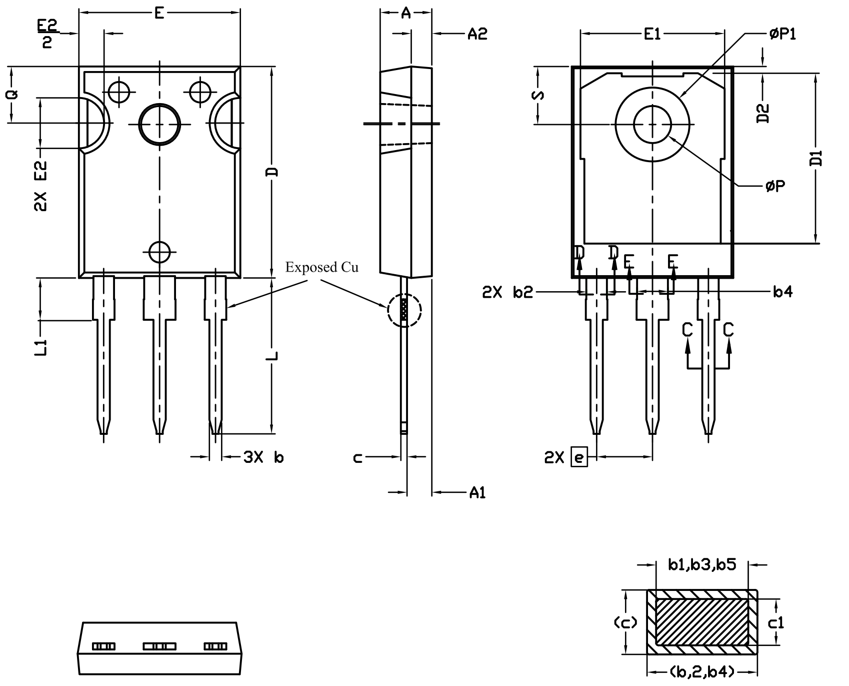
Note

a. V_{GS} = 5 V for logic level devices

Fig. 16. For N-Channel

TO-247AC (High Voltage)

VERSION 1: FACILITY CODE = 9



Section C--C, D--D, E--E

	MILLIMETERS		
DIM.	MIN.	MAX.	NOTES
A	4.83	5.21	
A1	2.29	2.55	
A2	1.50	2.49	
b	1.12	1.33	
b1	1.12	1.28	
b2	1.91	2.39	6
b3	1.91	2.34	
b4	2.87	3.22	6, 8
b5	2.87	3.18	
c	0.55	0.69	6
c1	0.55	0.65	
D	20.40	20.70	4

	MILLIMETERS		
DIM.	MIN.	MAX.	NOTES
D1	16.25	16.85	5
D2	0.56	0.76	
E	15.50	15.87	4
E1	13.46	14.16	5
E2	4.52	5.49	3
e	5.44 BSC		
L	14.90	15.40	
L1	3.96	4.16	6
Ø P	3.56	3.65	7
Ø P1	7.19 ref.		
Q	5.31	5.69	
S	5.54	5.74	

Notes

(1) Package reference: JEDEC® TO247, variation AC

(2) All dimensions are in mm

(3) Slot required, notch may be rounded

(4) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outermost extremes of the plastic body

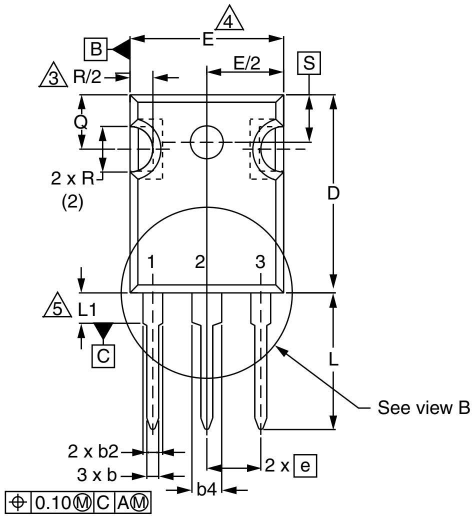
(5) Thermal pad contour optional with dimensions D1 and E1

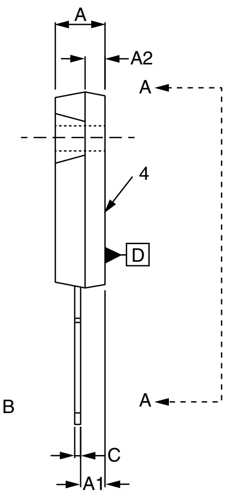
(6) Lead finish uncontrolled in L1

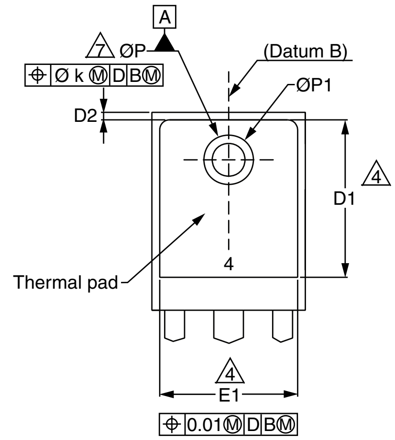
(7) Ø P to have a maximum draft angle of 1.5° to the top of the part with a maximum hole diameter of 3.91 mm

(8) Dimension b2 and b4 does not include dambar protrusion. Allowable dambar protrusion shall be 0.1 mm total in excess of b2 and b4 dimension at maximum material condition

VERSION 2: FACILITY CODE = Y

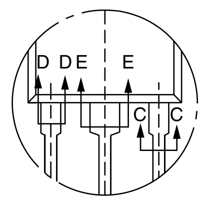




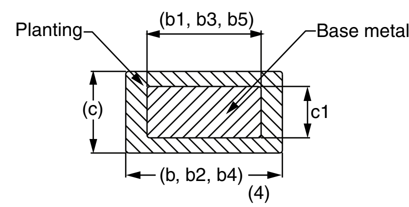


View A - A

Lead Assignments
1. Gate
2. Drain
3. Source
4. Drain



View B



Section C - C, D - D, E - E

	MILLIMETERS					MILLIMETERS		
DIM.	MIN.	MAX.	NOTES		DIM.	MIN.	MAX.	NOTES
A	4.58	5.31			D2	0.51	1.30	
A1	2.21	2.59			E	15.29	15.87	
A2	1.17	2.49			E1	13.72	-	
b	0.99	1.40			e	5.46 BSC		
b1	0.99	1.35			Ø k	0.254		
b2	1.53	2.39			L	14.20	16.25	
b3	1.65	2.37			L1	3.71	4.29	
b4	2.42	3.43			Ø P	3.51	3.66	
b5	2.59	3.38			Ø P1	-	7.39	
c	0.38	0.86			Q	5.31	5.69	
c1	0.38	0.76			R	4.52	5.49	
D	19.71	20.82			S	5.51 BSC		
D1	13.08	-						
ECN: E19-0614-Rev. E, 08-Jan-2020 DWG: 5971								

Notes

(1) Dimensioning and tolerancing per ASME Y14.5M-1994

(2) Contour of slot optional

(3) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body

(4) Thermal pad contour optional with dimensions D1 and E1

(5) Lead finish uncontrolled in L1

(6) Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154")

(7) Outline conforms to JEDEC outline TO-247 with exception of dimension c

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